

GaAs MMIC Power Amplifier Chip, 17-21GHz

Performance characteristics

Frequency range: 17-21GHz
 Small Signal Gain: 19 dB
 P-1dB: 30 dBm
 Psat: 30 dBm
 Power supply: + 6V @ 400mA
 50Ohm input/output
 100% on-chip testing
 Chip size : 2.6 x 1.22 x 0.1mm

Product Introduction

GPA -1721A is a broadband high-gain, high-efficiency, high- power amplifier chip based on GaAs technology , covering a frequency range of 17~21GHz, a small signal gain of 19dB, and a P-1 output power of 30dBm. The chip via metallization process ensures good grounding, and the back side is metallized for eutectic sintering process.

Use restriction parameter ¹

Maximum drain voltage	+8 V
Maximum gate bias	- 3 V
Maximum input power	+25 dBm
Operating temperature	-55 ~ +85°C
Storage temperature	-65 ~ +150°C

【1】 Exceeding any of these maximum limits may cause permanent damage.

Electrical parameters (Ta=+25°C, Vd=+ 6 V, Vg=-0.9V, Ids= 400 mA)

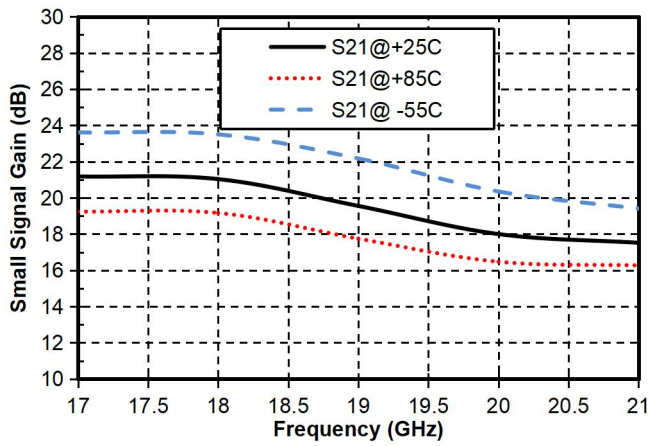
index	Minimum	Typical Value	Maximum	unit
Frequency Range	17-21			GHz
Small Signal Gain	17.5	19	21	dB
Gain Flatness	± 1.75			dB
P-1dB	29	30	30.5	dBm
Psat	29	30	30.5	dBm
Input return loss	9	14	-	dB
Output return loss	20	23	-	dB
Quiescent Current	400			mA

* By tuning the Vg terminal voltage -2V~0V , the recommended gate voltage is -0.9V.

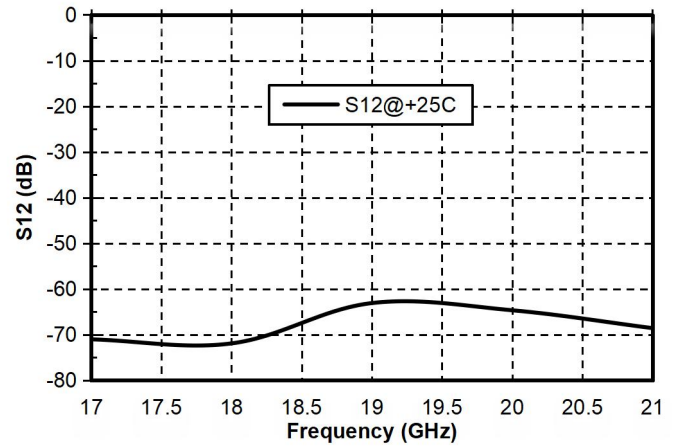
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Main index test curve

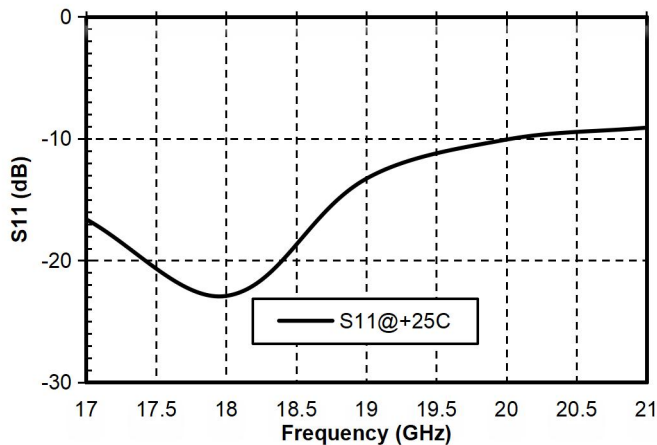
Gain vs. Frequency



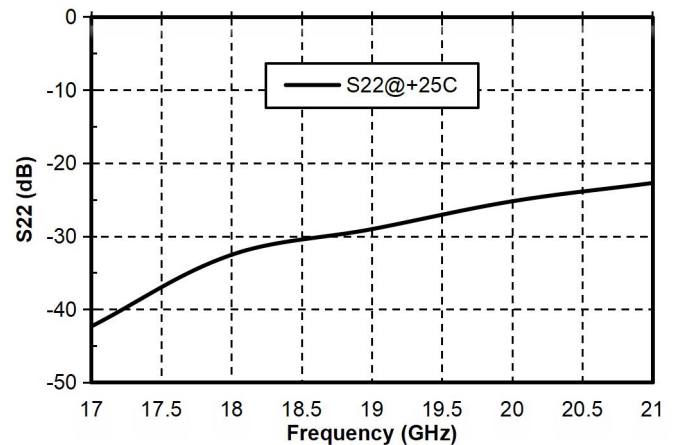
Reverse Isolation vs. Frequency



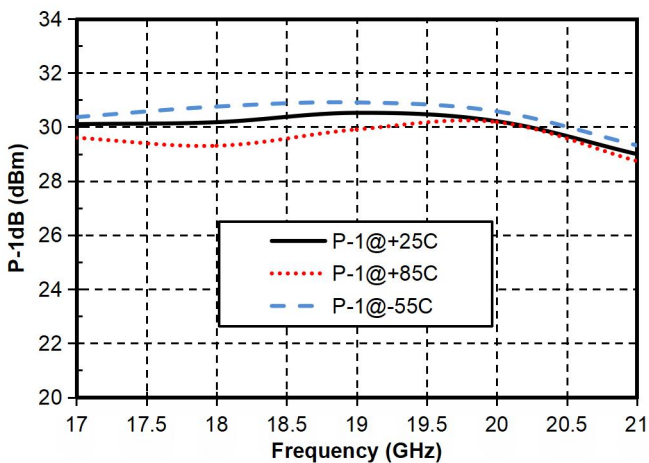
Input Return Loss vs. Frequency



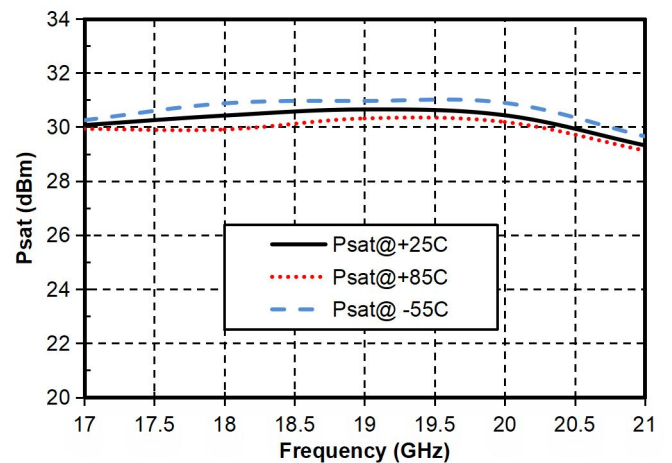
Output Return Loss vs. Frequency



P-1dB vs. Frequency

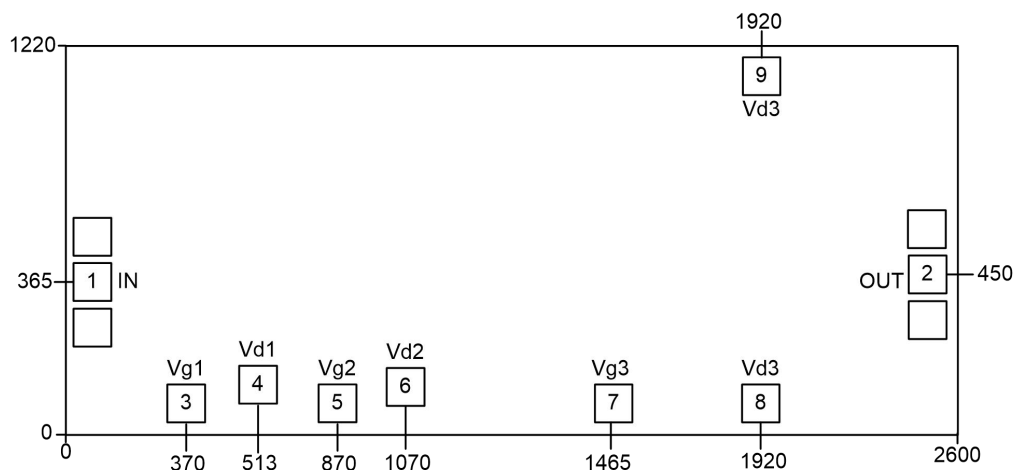


Psat vs. Frequency



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Appearance structure ²

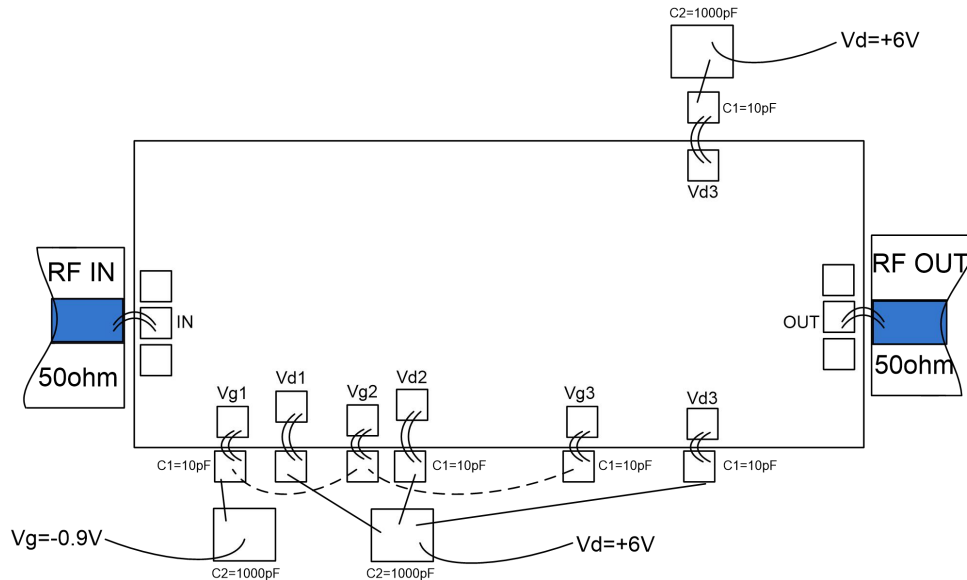


【 2 】 All units in the figure are micrometers

Bonding point definition		
Bonding point number	Function Symbol	Functional Description
1	RF IN	The signal input terminal is connected to a 50 ohm circuit, and no DC blocking capacitor is required.
2	RF OUT	The signal output terminal is connected to a 50 ohm circuit, and no DC blocking capacitor is required.
4, 6, 8, 9	Vd1 ~Vd3	Amplifier drain bias, external 10pF , 1000pF bypass capacitors are required.
3, 5, 7	VG1~3	Amplifier gate bias, external 10pF , 1000pF bypass capacitors are required.
Chip bottom	GND	The bottom of the chip needs to be in good contact with the RF and DC grounds.

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Recommended assembly diagram



raw material	Capacitance
C1	10pF
C2	1000pF

Notice

- The chip must be stored in an anti-static container and kept in a nitrogen environment.
- Do not attempt to clean the bare die surface using wet chemical methods.
- Please strictly follow the ESD protection requirements to avoid static damage to the bare chip.
- General operation: Please use precision pointed tweezers to pick up bare chips. Avoid touching the chip surface with tools or fingers during operation.
- Rack mounting operation suggestions: AuSn solder eutectic sintering process can be used for bare chip mounting. The mounting surface must be clean and flat.
- Sintering process: It is recommended to use AuSn solder sheets with a gold-tin ratio of 80/20. The working surface temperature reaches 255 °C and the tool (vacuum chuck) temperature reaches 265 °C . When the high-temperature mixed gas (nitrogen-hydrogen ratio of 90/10) is blown to the chip, the temperature at the top of the tool should be raised to 290 °C . Do not let the chip exceed 320 °C for more than 20 seconds. The friction time should not exceed 3 seconds.
- Bonding operation suggestions: Use $\Phi 0.025\text{mm}$ (1mil) gold wire for both ball and wedge bonding. Thermosonic bonding temperature is 150 °C . The pressure of the wedge bonding knife is 40~50gf for ball bonding and 18~22gf for wedge bonding. Use the smallest possible ultrasonic energy. The bonding starts at the pressure point on the chip and ends at the package (or substrate).